

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1878248	semiconductor or integrated adj circuit	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/26 08:22
L2	2767	1 and scan\$4 near chain\$1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/26 08:24
L3	1486	2 and latch\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/26 08:24
L4	4	3 and conductor near segment\$1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/26 08:27
L5	83	3 and transmission near gate\$1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/26 08:28
L6	4	("4855669" "5367551" "5416784" "5574731").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/26 09:02
L7	3	("5881067").URPN.	USPAT	OR	ON	2005/10/26 09:04
L8	4	("4945536" "5001713" "5130988" "5175447").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/26 09:05
L9	9	("5610927").URPN.	USPAT	OR	ON	2005/10/26 09:06
L10	9	("4495628" "4495629" "4553236" "4587480" "4621363" "4686627" "4752907" "4782283" "4799004").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/26 09:07
L11	44	("4947357").URPN.	USPAT	OR	ON	2005/10/26 09:09